FEDL5810A-05



30, Oct. 2020

ML5810A

High-Side Switch Driver IC for Battery Pack

■General Description

ML5810A is charge/discharge high-side switch Nch power MOSFET gate driver for battery pack. ML5810A assert external input reference voltage(CFS, DFS)+12V(typ) as the voltage for drive by charge pump. And also, built-in PchMOSFET gate driver for low current precharge in battery over-discharge state.

■ Features

•High-side switch Nch power MOSFET gate driver for battery pack protection

•Built-in Pch MOSFET gate driver for low current precharge/predischarge

•80V breakdown voltage applicable to 48V battery system

•Built-in charge pump

•Gate driver for charge/discharge "H" output voltage : Reference voltage(CFS, DFS)+10V (min) •Gate driver for precharge/predischarge "L" output voltage : Reference voltage (PCFS)-9V (min)

• Current consumption : 210uA(typ), 480uA(max)

• Power supply voltage range : +6.5V to +64V

(Absolute Maximum Rating: 80V)

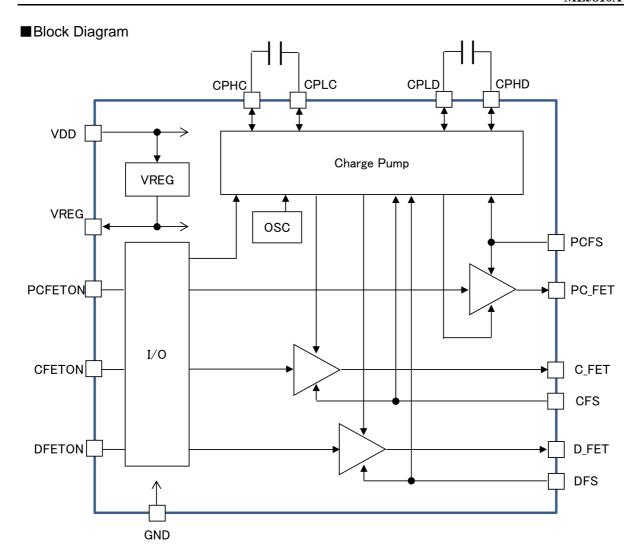
Operating temperature range : -40°C to +105°C
 Package : 20pin TSSOP

• Application : 12V to 48V Battery pack for industrial

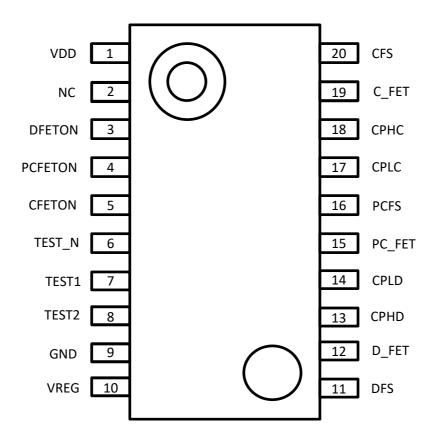
eBikes, Energy Storage Systems (ESS) and Uninterruptible Power Supplies (UPS)

Note) This product is not intended for automotive use and for any equipment, device, or system that requires a specific quality or high level of reliability (e.g., medical equipment, transportation equipment, aerospace machinery, nuclear-reactor controller, fuel-controller, various safety devices). If you are not sure whether your application corresponds to such special purposes, please contact your local ROHM sales representative in advance.





■Pin Configuration(Top View)



■Pin Description

Pin No.	Pin	I/O	Description
1	VDD	_	Power supply. Connect an external CR filter for noise rejection.
2	NC	_	
3	DFETON	I	D_FET enable input.(pulldown resistance:1M Ω)
4	PCFETON	ı	PC_FET enable input.(pulldown resistance:1MΩ)
5	CFETON	I	C_FET enable input.(pulldown resistance:1MΩ)
6	TEST_N	1	TEST_N input. Should be fixed to VDD.
7	TEST1	1	TEST1 input.(pulldown resistance:1M Ω) Should be fixed to GND.
8	TEST2	ı	TEST2 input.(pulldown resistance:1M Ω) Should be fixed to GND.
9	GND		Ground.
10	VREG	0	Built-in 3.3V regurator output. Connect a 4.7μF capacitor between this pin and GND.
11	DFS	1	Reference voltage input for the D_FET drive charge pump. Connect to the source pin of the discharge FET.
12	D_FET	0	Discharge Nch-FET gate drive. Connect to the gate pin of the external Nch-FET. In the ON state, the DFS level +12V (typ) is asserted. In the OFF state DFS level is asserted.
13	CPHD	0	Charge pump capacitor input for D_FET drive. Connect a capacitor which
14	CPLD	0	approximately 8-times of the discharge FET gate capacitance, between the CPHD and CPLD pins.
15	PC_FET	0	Precharge/predischarge Pch-FET gate drive. Connected to the gate pin of the external Pch-FET. In the ON state, the PCFS level -12V (typ) is asserted, while the PCFS level is asserted in the OFF state.
16	PCFS	I	Reference voltage input for the PC_FET drive charge pump. Connected to the source pin of the precharge/predischarge FET.
17	CPLC	0	Charge pump capacitor input for C_FET drive. Connect a capacitor with
18	СРНС	0	approximately twice the gate capacitance of the charge FET between the CPHC and CPLC pins.
19	C_FET	0	Charge Nch-FET gate drive. Connected to the gate pin of the external Nch-FET. In the ON state, the CFS level +12V (typ) is asserted, while the CFS level is asserted in the OFF state.
20	CFS	1	Reference voltage input for the C_FET drive charge pump. Connected to the source pin of the charge FET.

■ Absolute Maximum Ratings

			G	SND=0V, Ta=25°C
Parameter	Symbol	Condition	Rating	Unit
Supply voltage	V_{DD}	Applied to VDD pin	-0.3 to +86.5	V
	V _{IN1}	Applied to CFS,DFS, and PCFS pins	-0.3 to +86.5	V
Input voltage	V _{IN2}	Applied to CFETON, DFETON,PCFETON,TEST1, and TEST2,TEST_N pins	-0.3 to VDD+0.3	V
	V _{OUT1}	Applied to D_FET pin V _{DFS} =DFS pin voltage	V _{DFS} -0.5 to +86.5	V
Output voltage	V _{OUT2}	Applied to C_FET pin V _{CFS} =CFS pin voltage V _{CFS} -0.5 to +86.5		V
	V _{ОUТ3}	Applied to PC_FET pin	-0.5 to +71.5	V
	l _{OS1}	VDD=50V Applied to VREG pin	5	mA
Short circuit output current	I _{OS2}	VDD=50V Applied to C_FET and D_FET pins	20	mA
	los3	VDD=50V Applied to PC_FET pin	2	mA
Power dissipation	dissipation P _D Ta=25°C		2.3	W
Package thermal resistance	θ ja	JEDEC double-side board mounted	33.7	°C/W
Storage temperature	T _{STG}	_	-55 to +150	°C

■ Recommended Operating Conditions

(GND= 0 V)

Parameter	Symbol Condition		Range	Unit
Power supply voltage	V_{DD}	Applied to VDD pin	6.5~64	V
Operating temperature	Та	No VREG output load	-40 ~ +105	°C

■ Electrical Characteristics

 V_{DD} =6.5 \sim 64V,GND=0V,Ta=-40 to +105°C, no VREG output load

V _{DD} =6.5~64V,GND=0V,Ta=-40 to +105°C, no VREG output load						
Parameter	Symbol	Condition	Min.	Тур.	Max.	Unit
Digital "H" input voltage(*1)	ViH	_	2.15	_	VDD+0.3	V
Digital "L" input voltage(*1)	VIL	_	0	_	0.35	V
Digital "H" input current(*1)	Іін	V _{IH} = VDD	_	_	130	μΑ
Digital "L" input current(*1)	lı∟	V _{IL} = GND	-2	_	_	μΑ
C_FET / D_FET output voltage(C_FET-CFS,	V _{OH11}	I _{OH} =-1.5µА (V _{DD} *0.95)≧10V	10	12	15	V
D_FET-DFS)	V _{OH12}	I _{OH} =-1.5µА (V _{DD} *0.93)<10V	V _{DD} *0.93	_	V_{DD}	V
PC_FET output voltage	V _{OL21}	l _{OL=+} 1.5μΑ (V _{DD} *0.8)≧9V	9	12	15	V
(PCFS-PC_FET)	V _{OL22}	I _{OL} =+1.5μΑ (V _{DD} *0.8)<9V	V _{DD} *0.8	_	V_{DD}	V
C_FET / D_FET rise time	Tfetr1	Ccp=80nF, Rg=1kΩ, Rfs=100Ω, FET gate capacitance=10nF From FET-on to 80% of output voltage Voh11, Voh12	_	150	350	us
C_FET / D_FET fall time	Tfetf1	Ccp=80nF, Rg=1kΩ, Rfs=100Ω, FET gate capacitance=10nF From FET-off to 20% of output voltage VoH11, VoH12	_	40	70	us
PC_FET fall time	Tfetf2	$\label{eq:ccp=80nF} Ccp=80nF, \\ Rg=1k\Omega, Rfs=1k\Omega, \\ FET gate capacitance=1nF \\ From FET-on to 80\% of \\ output voltage V_{OL21}, V_{OL22}$	_	110	400	us
PC_FET Rg= rise time Tfetr2 FET gar From		Ccp=80nF, Rg=1k Ω , Rfs=1k Ω , FET gate capacitance=1nF From FET-off to 20% of output voltage Vol21, Vol22	_	20	70	us
Current consumption in operation (charge and discharge) (*2)	ration ration IDD1 CFETON=1 & DFETON=1 & PCFETON=0 VDD-CFS-DFS-PCFS		_	210	480	uA
Current consumption in operation (precharge or predischarge)(*2)	IDD2	CFETON=0 & DFETON=0 & PCFETON=1 VDD=CFS=DFS=PCFS	_	135	380	uA

VREG output voltage V _{REG1}		V _{DD} =6.5V∼64V Output load current<1mA	3.0	3.3	3.6	V
C_FET / D_FET charge pump frequency	F _{CPCD}	_	6.25	7.8125	9.4	kHz
PC_FET charge pump frequency	FCPPC	_	0.78	0.9766	1.2	kHz

^{*1:} Applied to CFETON, DFETON, PCFETON, TEST1, TEST2 and TEST_N pins

^{*2:} Current consumption are sum of VDD,CFS,DFS, and PCFS currents

■Functional Description

Operating state of ML5810A in each input status of 3 control input(PCFETON, DFETON, CFETON) is indicated in the following table.

"Charge pump ON, FET stand-by" is in which a charge pump powers up and each FET gate voltage output enable. The wait time is required at transition from power-up, and please refer to the "Timing diagram" mentioned later for details.

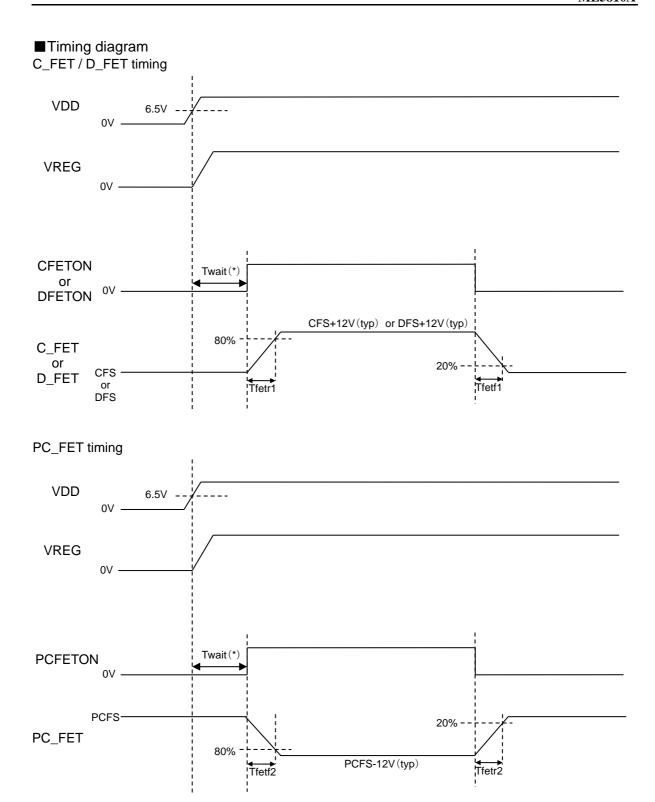
"FET ON state" is the state in which each FET gate voltage is asserted by a relevant pin actually. Please refer to "

electrical characteristic" about rise and fall time of gate voltage.

	Input		ML5810A
PCFETON	DFETON	CFETON	Operating status
0	0	0	Charge pump ON, FET stand-by
Mo	re than one is	"1"	FET ON

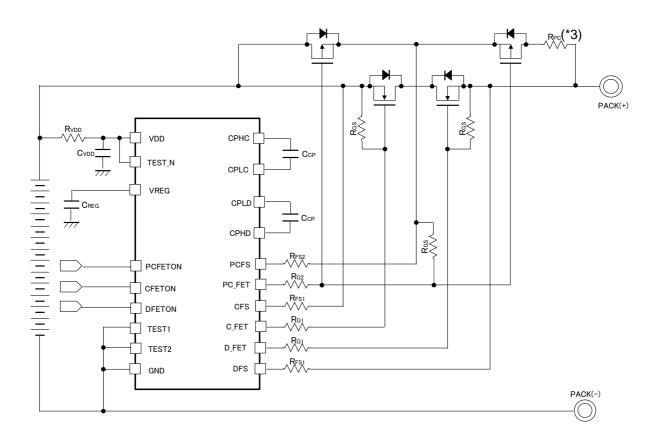
C_FET and D_FET can be turn on at the same time, but PC_FET is exclusively other FETs and can't be turn on at the same time. A truth table of FET ON/OFF is following. As it's shown on the table, CFETON, DFETON is priority more than PCFETON .

	Input		Output		
PCFETON	DFETON	CFETON	PC_FET	D_FET	C_FET
0	0	0	OFF	OFF	OFF
0 or 1	0	1	OFF	OFF	ON
0 or 1	1	0	OFF	ON	OFF
0 or 1	1	1	OFF	ON	ON
1	0	0	ON	OFF	OFF



(*) Twait must be more than 50ms, when CFETON, DFETON, and PCFETON are set to H from L (0v).

■Application Circuit Example



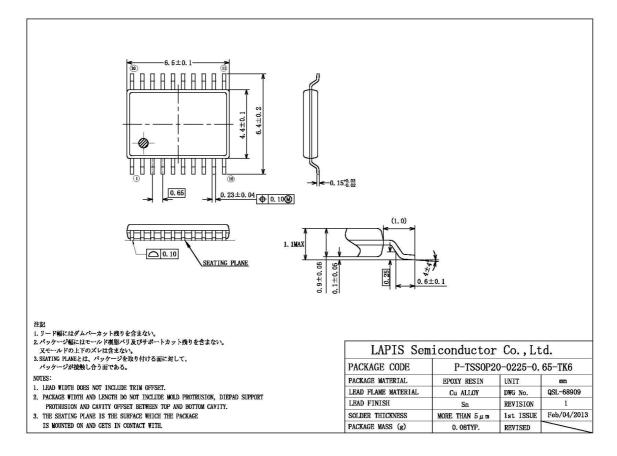
Recommended Values for External Components

Component	Recommended value
R _{VDD} (*1)	510Ω to 1.5 kΩ
C_{VDD}	2.2μF to 10μF
C _{REG}	4.7μF
R _{G1}	1kΩ
R _{FS1}	100Ω
R _{G2}	1kΩ
R _{FS2}	1kΩ
R _{GS}	10ΜΩ
C _{CP}	82nF (*2)

- (*1) Recommended $R_{VDD}{=}1.5k\Omega$ for $C_{VDD}{=}2.2\mu F.$
- (*2) Set 80nF to 100nF, when gate capacitance of external Nch-FET is 10nF. Set about 8-times of gate capacitance of external Nch-FET to C_{CP}.
- (*3) Set R_{PC} according to current of Pch-FET.

Notice: Example of application circuit and the recommended values to parts list shall not guarantee performance under all conditions. Full and detailed tests are suggested on your actual application.

■ Package Dimensions



Causion regarding surface mount type packages

Surface mount type packages are susceptible to applied heat in solder reflow or moisture absorption during storage. Please contact your local ROHM sales representative for the recommended mounting conditions (reflow sequence, temperature and cycles) and storage environment.

■ Revision History

Document No.	Issue date	Page		Descriptions	
Document No.	issue date	Previous	New	Descriptions	
Version-02	2019.07.18	_		English version first edition issued	
Version-03	2019.07.19	3	3	Error in writing corrected	
Version-03	2019.07.25	5,10	5,10	Error in writing corrected	
Version-04	2020.06.05	3	3	Error in Pin Configuration corrected (pin 2,8,15,16)	
Version-04	2020.06.05	10	10	■Application Circuit Example Added TEST1, TEST2, TEST_N pin.	
Version-05	2020.10.30	_		Changed Company name and "notes" page.	

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